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Build in Biasing Circuit MOS FET IC VHF&UHF RF Amplifier



ADE-208-982E (Z) 6th. Edition Mar. 2001

Features

- Build in Biasing Circuit; To reduce using parts cost & PC board space.
- Low noise; NF = 1.0 dB typ. at f = 200 MHz, NF = 1.75 dB typ. at f = 900 MHz
- High gain; PG = 30 dB typ. at f = 200 MHz, PG = 22 dB typ. at f = 900 MHz
- Withstanding to ESD;
 Build in ESD absorbing diode. Withstand up to 200 V at C = 200 pF, Rs = 0 conditions.
- Provide mini mold packages; MPAK-4 (SOT-143Rmod)

Outline

MPAK-4



- 1. Source
- 2. Gate1
- 3. Gate2
- 4. Drain

Notes: 1. Marking is "DS-".

2. BB504M is individual type number of HITACHI BBFET.

Absolute Maximum Ratings (Ta = 25°C)

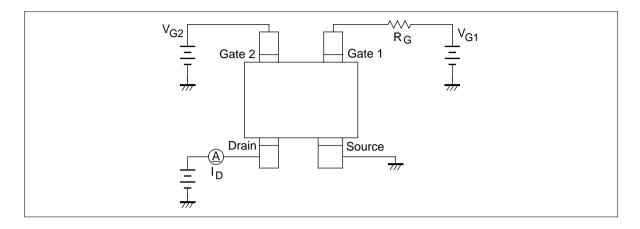
Item	Symbol	Ratings	Unit	
Drain to source voltage	V_{DS}	6	V	
Gate1 to source voltage	$V_{\sf G1S}$	+6 -0	V	
Gate2 to source voltage	$V_{\sf G2S}$	+6 -0	V	
Drain current	I _D	30	mA	
Channel power dissipation	Pch	150	mW	
Channel temperature	Tch	150	°C	
Storage temperature	Tstg	-55 to +150	°C	

Electrical Characteristics (Ta = 25°C)

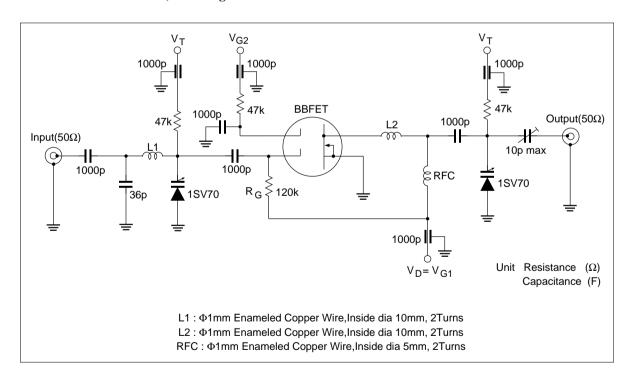
Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	6	_	_	V	$I_D = 200\mu A, V_{G1S} = V_{G2S} = 0$
Gate1 to source breakdown voltage	$V_{(BR)G1SS}$	+6	_	_	V	$I_{G1} = +10\mu A, V_{G2S} = V_{DS} = 0$
Gate2 to source breakdown voltage	$V_{(BR)G2SS}$	+6	_	_	V	$I_{G2} = +10\mu A, V_{G1S} = V_{DS} = 0$
Gate1 to source cutoff current	I _{G1SS}	_	_	+100	nA	$V_{G1S} = +5V, V_{G2S} = V_{DS} = 0$
Gate2 to source cutoff current	I _{G2SS}	_	_	+100	nA	$V_{G2S} = +5V, V_{G1S} = V_{DS} = 0$
Gate1 to source cutoff voltage	$V_{\text{G1S(off)}}$	0.6	0.85	1.1	V	$V_{DS} = 5V, V_{G2S} = 4V, I_{D} = 100\mu A$
Gate2 to source cutoff voltage	$V_{G2S(off)}$	0.6	0.85	1.1	V	$V_{DS} = 5V, V_{G1S} = 5V, I_{D} = 100\mu A$
Drain current	I _{D(op)}	13	16	19	mA	$V_{DS} = 5V, V_{G1} = 5V$ $V_{G2S} = 4V, R_G = 120k\Omega$
Forward transfer admittance	y _{fs}	24	29	34	mS	$V_{DS} = 5V, V_{G1} = 5V, V_{G2S} = 4V$ $R_{G} = 120k\Omega, f = 1kHz$
Input capacitance	C _{iss}	1.7	2.1	2.5	pF	$V_{DS} = 5V, V_{G1} = 5V$
Output capacitance	C _{oss}	1.0	1.4	1.8	pF	V_{G2S} =4V, R_{G} = 120k Ω
Reverse transfer capacitance	C _{rss}	_	0.027	0.05	pF	f = 1MHz
Power gain (1)	PG	25	30	_	dB	$V_{DS} = 5V, V_{G1} = 5V$ $V_{G2S} = 4V, R_{G} = 120k\Omega$
Noise figure (1)	NF	_	1.0	1.8	dB	f = 200MHz
Power gain (2)	PG	17	22	_	dB	$V_{DS} = 5V, V_{G1} = 5V$ $V_{G2S} = 4V, R_{G} = 120k\Omega$
Noise figure (2)	NF	_	1.75	2.3	dB	f = 900MHz

Test Circuits

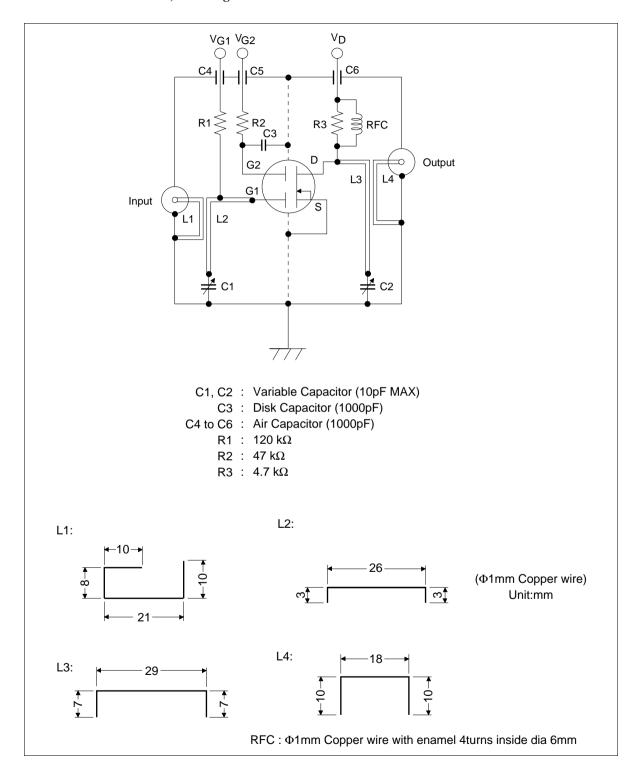
 $\bullet \ \ \textbf{DC Biasing Circuit for Operating Characteristics Items} \ (I_{D(op)}, |yfs|, Ciss, Coss, Crss, NF, PG) \\$



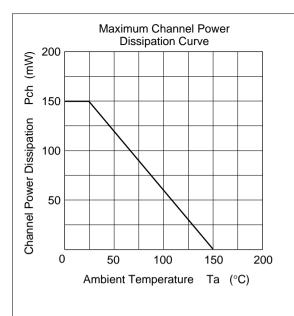
• 200 MHz Power Gain, Noise Figure Test Circuit

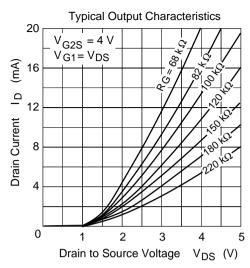


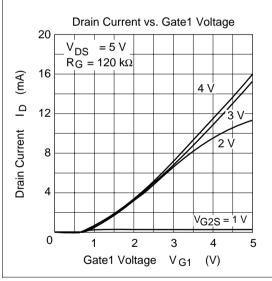
• 900 MHz Power Gain, Noise Figure Test Circuit

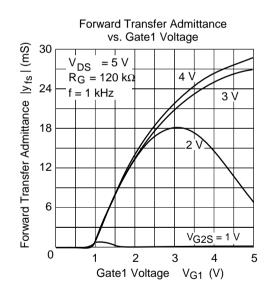


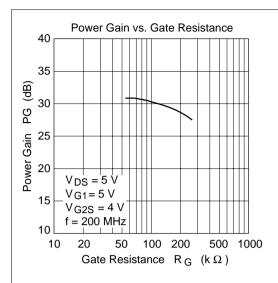
RENESAS

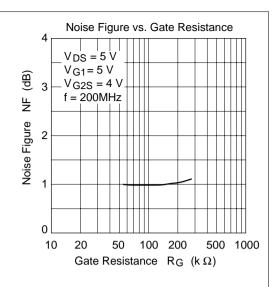


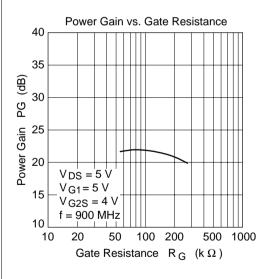


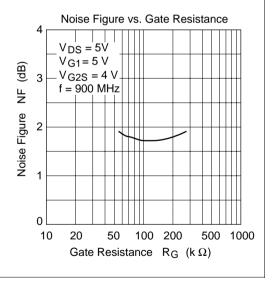


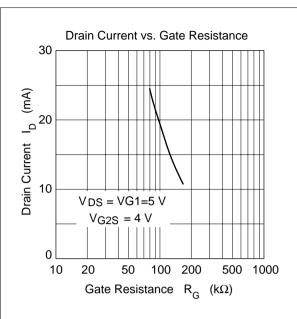


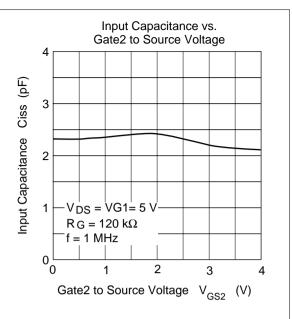


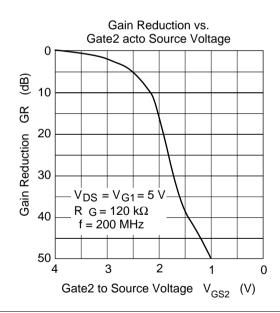


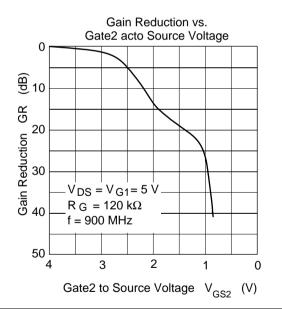




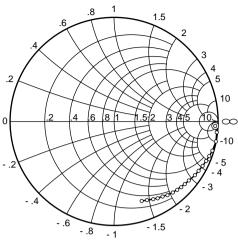






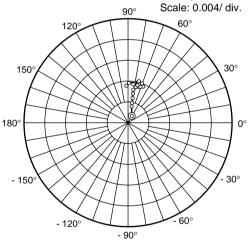


S11 Parameter vs. Frequency



Test Condition: V_{DS} = 5 V, V_{G1} = 5 V V_{G2S} = 4 V, R_G = 120 k Ω , Z_0 = 50 Ω 50 to 1000 MHz (50 MHz step)

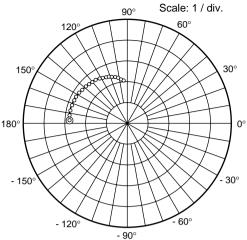
S12 Parameter vs. Frequency



Test Condition: V_{DS} = 5 V, V _{G1} = 5 V $V_{G2S} = 4 \text{ V, R}_{G} = 120 \text{ k } \Omega,$ Zo = 50 Ω

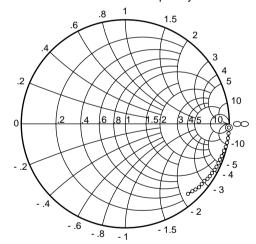
50 to 1000 MHz (50 MHz step)

S21 Parameter vs. Frequency



Test Condition: V_{DS} = 5 V, V G₁ = 5 V $V_{G2S} = 4 \text{ V, R}_{G} = 120 \text{ k}\Omega,$ Zo = 50 Ω 50 to 1000 MHz (50 MHz step)

S22 Parameter vs. Frequency

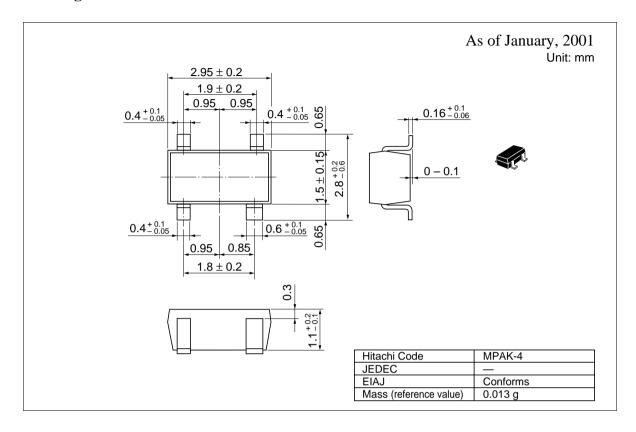


Test Condition: V_{DS} = 5 V, V G1 = 5 V V_{G2S} = 4 V, R_G = 120 k Ω , Zo = 50 Ω 50 to 1000 MHz (50 MHz step)

Sparameter	$(V_{DS} =$	$V_{G1} = 5V$	$V_{G2S} = 4$	$V, R_{G} = 12$	$0 \text{ k}\Omega, \text{ Zo} = 50 \Omega)$
------------	-------------	---------------	---------------	-----------------	--

	S11		S21	S21			S22	S22	
f (MHz)	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG	
50	1.000	-3.3	2.80	175.9	0.00106	58.8	0.990	-2.4	
100	0.993	-7.2	2.78	170.9	0.00171	75.7	0.992	-4.7	
150	0.991	-10.9	2.77	166.1	0.00253	75.1	0.991	-7.2	
200	0.984	-15.0	2.74	161.2	0.00356	77.4	0.987	-9.6	
250	0.978	-19.0	2.72	156.5	0.00442	78.2	0.985	-12.2	
300	0.970	-22.8	2.68	151.8	0.00485	80.0	0.982	-14.7	
350	0.958	-26.7	2.64	147.2	0.00576	74.7	0.978	-17.1	
400	0.954	-30.3	2.60	142.7	0.00642	71.7	0.973	-19.6	
450	0.945	-33.8	2.56	138.6	0.00689	73.3	0.968	-22.0	
500	0.932	-37.5	2.50	134.1	0.00712	71.8	0.963	-24.2	
550	0.920	-40.6	2.46	129.8	0.00765	70.7	0.958	-26.7	
600	0.910	-44.3	2.41	125.7	0.00804	69.9	0.952	-28.9	
650	0.900	-47.5	2.37	121.6	0.00798	69.1	0.947	-31.3	
700	0.887	-50.9	2.31	117.8	0.00787	67.8	0.942	-33.4	
750	0.870	-54.4	2.27	113.6	0.00785	70.8	0.936	-35.8	
800	0.863	-57.6	2.22	110.0	0.00758	73.3	0.929	-37.9	
850	0.853	-60.9	2.18	105.8	0.00721	75.2	0.924	-40.3	
900	0.839	-63.6	2.12	102.2	0.00694	75.8	0.917	-42.5	
950	0.827	-66.5	2.07	98.6	0.00716	88.1	0.912	-44.5	
1000	0.819	-70.1	2.04	94.9	0.00667	92.7	0.906	-46.7	

Package Dimensions



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